Test Report: LRS-35-24

35W Single Output Switching Power Supply

■ DESIGN VERIFY TEST

Output Function Test
Input Function Test
Protection Function Test
Component Stress Test

■ SAFETY & E.M.C. TEST

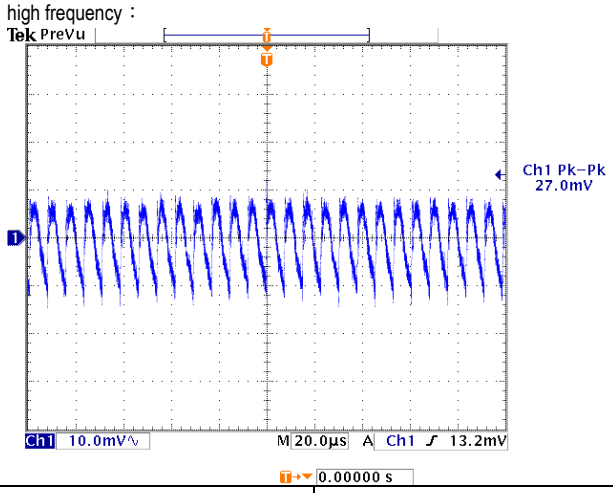
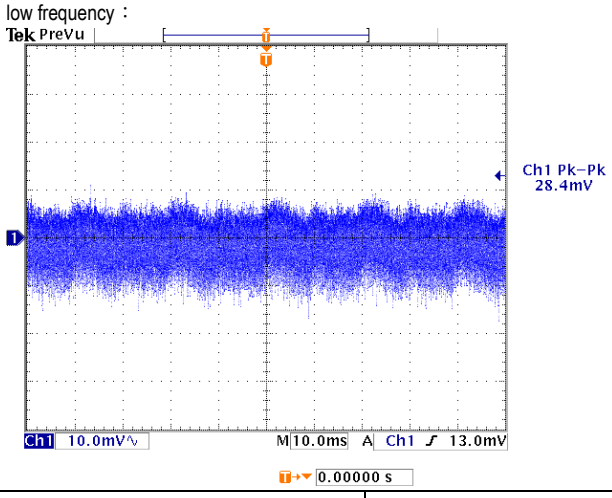
Safety Test
E.M.C. Test

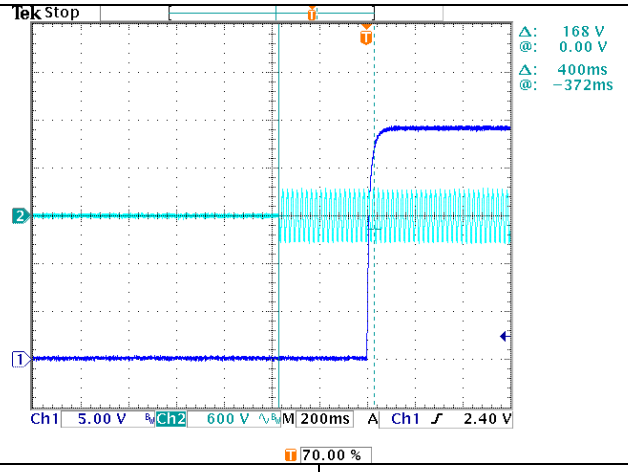
■ RELIABILITY TEST

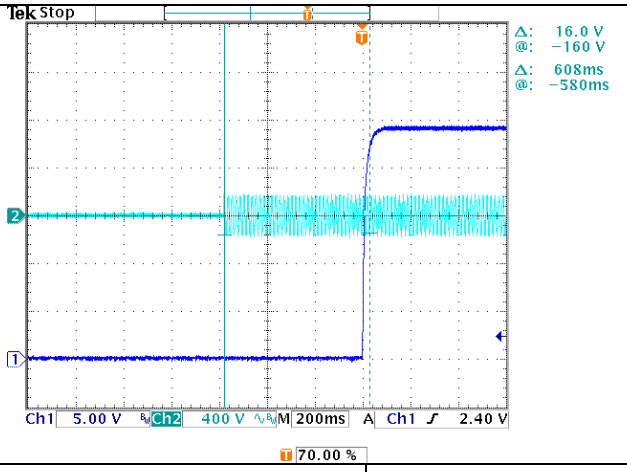
ENVIRONMENT TEST

■ DESIGN VERIFY TEST

OUTPUT FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	OUTPUT VOLTAGE ADJUST RANGE	CH1: 21.6V~ 28.8 V	I/P： 230 VAC I/P： 115 VAC O/P：MIN LOAD Ta：25℃	20.54V~30.36V/230VAC 20.54V~30.36V/115VAC
2	OUTPUT VOLTAGE(Max) TOLERANCE	V1: 1 %~ -1 %	I/P: 100VAC /264VAC O/P:FULL/ MIN. LOAD Ta:25℃	V1: -0.025 %~ 0.025%
3	LINE REGULATION (Max)	V1: 0.5 %~ -0.5 %	I/P: 100VAC~ 264VAC O/P:FULL LOAD Ta:25℃	V1: 0%~ 0.025 %
4	LOAD REGULATION(Max)	V1: 0.5 %~ -0.5 %	I/P: 230VAC O/P:FULL ~MIN LOAD Ta:25℃	V1: -0.025%~ 0 %
5	OVER/UNDERSHOOT TEST	< ±5%	I/P: 230VAC O/P:FULL LOAD Ta:25℃	< ±5%
6	RIPPLE & NOISE(Max)	V1: 150mVp-p	I/P:230VAC O/P:FULL LOAD Ta:25℃	V1: 28.4mVp-p
	high frequency： 		low frequency： 	
7	SET UP TIME(Max)	230VAC/1000ms 115VAC/2000ms	I/P： 230 VAC I/P： 115 VAC O/P：FULL LOAD Ta：25℃	230VAC/ 400ms 115VAC/ 608ms
	INPUT=230VAC/50HZ @ FULL LOAD CH1 : Output Voltage CH2 : AC Input Voltage		INPUT=115VAC/60HZ @ FULL LOAD CH1 : Output Voltage CH2 : AC Input Voltage	

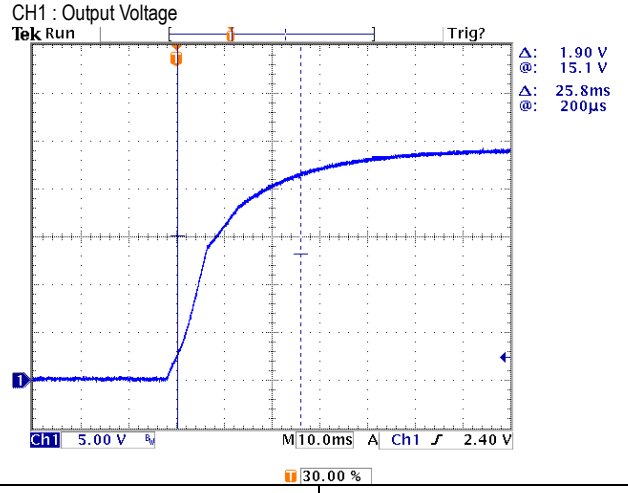




8	RISE TIME (Max)	230VAC/30ms 115VAC/30ms	I/P： 230 VAC I/P： 115 VAC O/P：FULL LOAD Ta：25℃	230VAC/25.8ms 115VAC/ 25.2ms

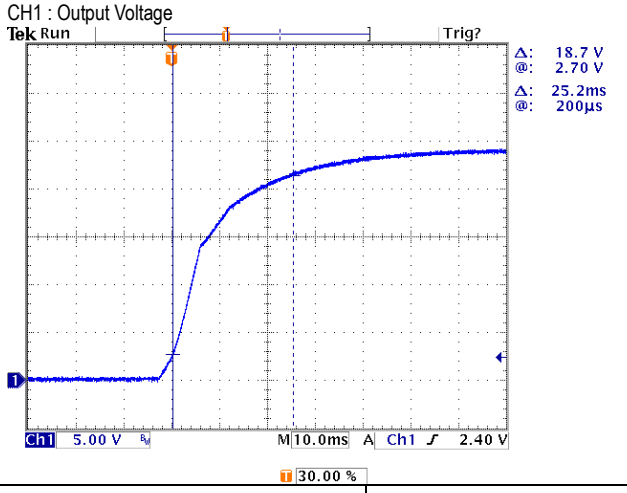
INPUT=230VAC/50HZ @ FULL LOAD

CH1 : Output Voltage



INPUT=115VAC/60HZ @ FULL LOAD

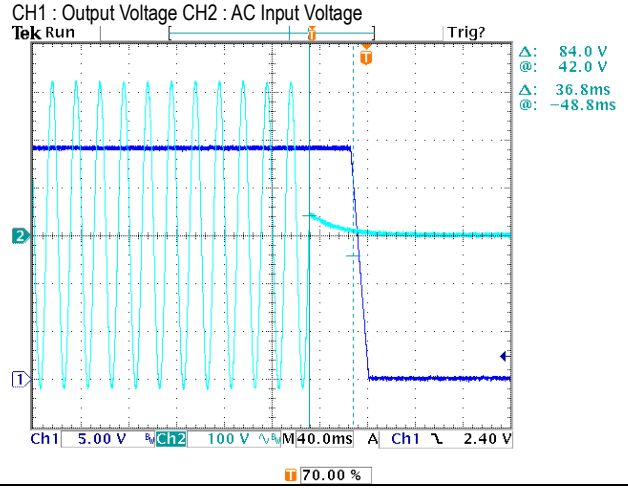
CH1 : Output Voltage



9	HOLD UP TIME (Typ.)	230VAC/30ms 115VAC/12ms	I/P： 230 VAC I/P： 115 VAC O/P：FULL LOAD Ta：25℃	230VAC/36.8ms 115VAC/ 17.6ms

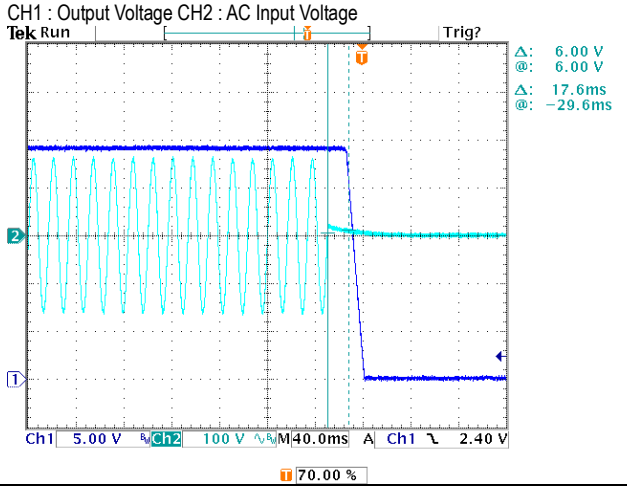
INPUT=230VAC/50HZ @ FULL LOAD

CH1 : Output Voltage CH2 : AC Input Voltage



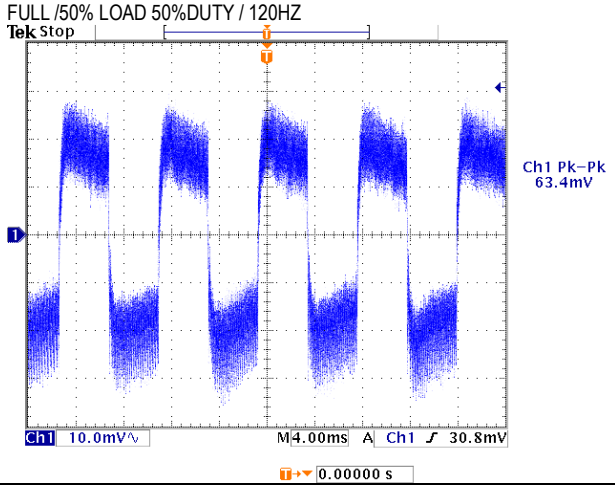
INPUT=115VAC/60HZ @ FULL LOAD

CH1 : Output Voltage CH2 : AC Input Voltage

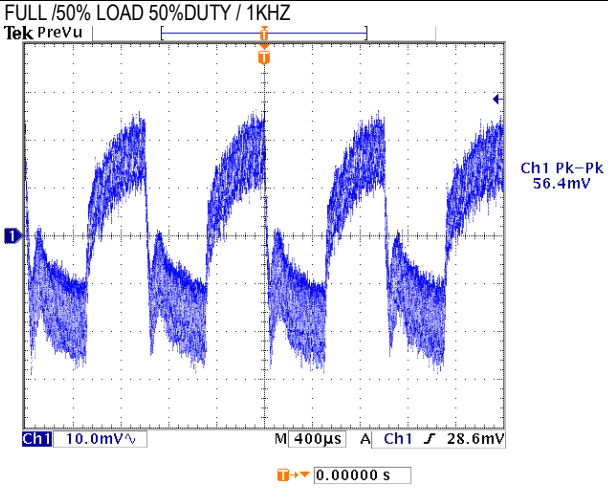


10	DYNAMIC LOAD	V1: 2400 mVp-p	I/P: 230VAC O/P: (1)FULL /50% LOAD 50%DUTY / 120HZ (2)FULL /50% LOAD 50%DUTY / 1KHZ Ta:25℃	 63.4mVp-p 56.4mVp-p

FULL /50% LOAD 50%DUTY / 120HZ



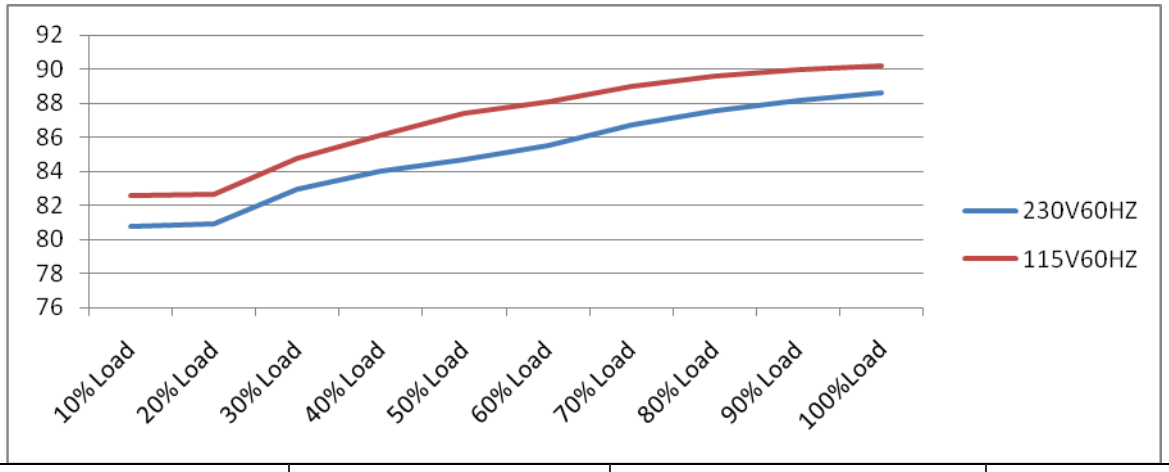
FULL /50% LOAD 50%DUTY / 1KHZ



INPUT FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	INPUT VOLTAGE RANGE	85VAC~264VAC	I/P:TESTING O/P:FULL LOAD Ta:25℃	63V~264V
			I/P: (1)LOW-LINE-3V=82 V HIGH-LINE+15%=300 V O/P:FULL/MIN LOAD (PLEASE CHECK DERATING CURVE) ON: 30 Sec OFF: 30 Sec 10MIN (2)230Vac ON: 0.5 Sec OFF: 0.5 Sec 20MIN (3)230Vac ON:3Sec OFF:3Sec 12HOURS (POWER ON/OFF NO DAMAGE)	TEST:OK
2	INPUT FREQUENCY RANGE	47HZ ~63 HZ NO DAMAGE	I/P:100 VAC ~264 VAC O/P:FULL~MIN LOAD Ta:25℃	TEST: OK
3	INPUT CURRENT (Typ.)	230V/ 0.42A 115V/ 0.70A	I/P ： 230 VAC I/P ： 115 VAC O/P ：FULL LOAD Ta ：25℃	I =0.347A/ 230VAC I =0.576A/ 115VAC
4	LEAKAGE CURRENT	<0.75 mA / 240 VAC	I/P ： 240 VAC O/P ：Min LOAD Ta ：25℃	L-FG ： 0.518 mA N-FG ： 0.518 mA
5	NO LOAD CONSUMPTION	< 0.2W	I/P ：115VAC I/P ：230VAC O/P ：NO LOAD Ta ：25℃	< 0.0795 W < 0.0686 W
6	EFFICIENCY(Typ.)	88%	I/P:230 VAC O/P:FULL LOAD Ta:25℃	88.39%

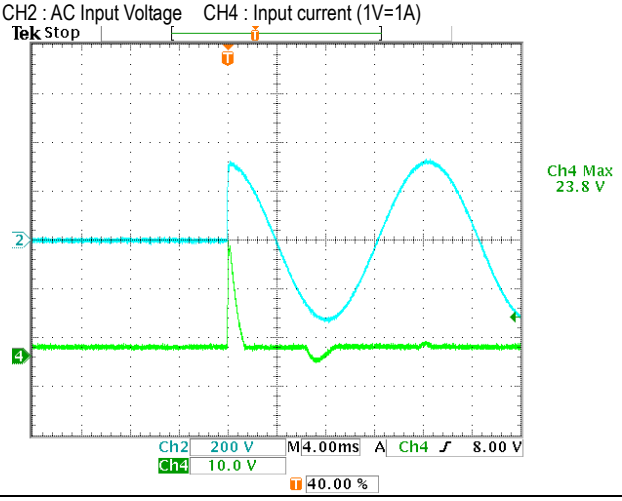
EFFICIENCY vs LOAD



7	INRUSH CURRENT(Typ.)	230V/40A COLD START	I/P： 230 VAC O/P：FULL LOAD Ta：25℃	I =23.8A/ 230VAC

INPUT=230VAC/50HZ @ FULL LOAD

CH2 : AC Input Voltage CH4 : Input current (1V=1A)



PROTECTION FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	OVER LOAD PROTECTION	110 %~ 150 %	I/P: 264VAC I/P: 230VAC I/P: 100VAC O/P:TESTING Ta:25℃	131.33%/ 264VAC 129.33%/ 230VAC 128.67%/100VAC PROTECTION TYPE： Hiccup mode, recovers automatically after fault condition is removed
2	OVER VOLTAGE PROTECTION	28.8V~33.6 V	I/P: 264VAC I/P: 230VAC I/P: 85VAC O/P:MIN LOAD Ta:25℃	31.5V/ 264VAC 31.5V/ 230VAC 31.5V/ 85VAC PROTECTION TYPE： Shut down o/p voltage, re-power on to recover
3	SHORT PROTECTION	SHORT EVERY OUTPUT 1 HOUR NO DAMAGE	I/P: 264VAC I/P: 85VAC O/P: FULL LOAD Ta:25℃	NO DAMAGE PROTECTION TYPE： Hiccup mode, recovers automatically after fault condition is removed

COMPONENT STRESS TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	PWM Transistor (D to S) or (C to E) **Peak Voltage**	Q 1 Rated 6A/ 600 V	I/P:High-Line +3V =267V AC ON/OFF VDS: O/P: (1)Full Load (2)Output Short (3)Full load continue Ta:25℃	 VDS: (1) 510V (2) 414V (3) 510V
2	Diode Peak **Voltage**	Q100 Rated 10A/200 V	I/P:High-Line +3V =267 V AC ON/OFF O/P: (1)Full Load (2)Output Short (3)Full load continue Ta:25℃	Q100: VDS: (1) 118V (2) 94.8V (3) 116V
3	**Input Capacitor Voltage**	C5 Rated: :68 μ / 400 V 105 ℃	I/P:High-Line +3V =267 V O/P: (1)Full Load input on/off (2) Min load input on /Off (3)Full Load /Min load Change Ta:25℃	(1) 376V (2)370 V (3) 372V
4	**Control IC Voltage Test**	PWM IC U1 Rated 10.8 V~30V	I/P:High-Line +3V =267 V AC ON/OFF O/P(1)FULL LOAD (2) Output Short (3)O.L.P (4)O.V.P. (5)NO LOAD VR Min. LOW LINE Ta:25℃	(1) 17.0V (2) 15.0V (3) 15.0V (4) 20.8V (5) 14.9V
5	Clamp Diode Peak Voltage	D5 Rated： 3A/600V	I/P：High-Line +3V = 267 V AC ON/OFF O/P： (1) Dynamic Load 90%Duty/1KHz (2)Full load continue Ta：25℃	(1) 462V (2) 464V

SAFETY TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	WITHSTAND VOLTAGE	I/P-O/P: 3.75KVAC/min I/P-FG :2KVAC/min O/P-FG:1.25KVAC/min	I/P-O/P: 4.125KVAC/min I/P-FG: 2.4 KVAC/min O/P-FG:1.5 KVAC/min Ta:25℃	I/P-O/P:2.663mA I/P-FG:3.74mA O/P-FG:3.31m A NO DAMAGE
2	ISOLATION RESISTANCE	I/P-O/P:500VDC>100MΩ I/P-FG: 500VDC>100MΩ O/P-FG:500VDC>100MΩ	I/P-O/P: 500 VDC I/P-FG: 500 VDC O/P-FG: 500 VDC Ta:25℃	I/P-O/P: 9999MΩ I/P-FG: 9999MΩ O/P-FG: 9999MΩ NO DAMAGE
3	GROUNDING CONTINUITY	FG(PE) TO CHASSIS OR TRACE < 100 mΩ	40A / 2min Ta:25℃	21 mΩ

E.M.C TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	HARMONIC	EN61000-3-2 CLASS A	I/P:230VAC/50HZ O/P:100%LOAD Ta:25℃	PASS
2	CONDUCTION	EN55022 CLASS B	I/P： 230 VAC (50HZ) O/P：FULL/50% LOAD Ta：25℃	PASS Test by certified Lab
3	RADIATION	EN55022 CLASS B	I/P： 230 VAC (50HZ) O/P：FULL LOAD Ta：25℃	PASS Test by certified Lab
4	E.S.D	EN61000-4-2 INDUSTRY AIR：8KV / Contact：4KV	I/P： 230 VAC/50HZ O/P：FULL LOAD Ta：25℃	CRITERIA A
5	E.F.T	EN61000-4-4 INDUSTRY INPUT： 2KV	I/P： 230 VAC/50HZ O/P：FULL LOAD Ta：25℃	CRITERIA A
6	SURGE	IEC61000-4-5 INDUSTRY L-N ：2KV L,N-PE：4KV	I/P： 230 VAC/50HZ O/P：FULL LOAD Ta：25℃	CRITERIA A
7	Test by certified Lab & Test Report Prepare			

RELIABILITY TEST

ENVIRONMENT TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	TEMPERATURE RISE TEST	MODEL： LRS-35-24 1. ROOM AMBIENT BURN-IN：2 HRS I/P： 230VAC O/P： FULL LOAD Ta=24.8℃ 2. HIGH AMBIENT BURN-IN： 2 HRS I/P： 230VAC O/P： FULL LOAD Ta=50.1℃		
2	OVER LOAD BURN-IN TEST	NO DAMAGE 1 HOUR (MIN)	I/P： 230 VAC O/P：133% LOAD Ta：25℃	TEST：OK

NO	Position	ROOM AMBIENT Ta= 24.8 ℃	HIGH AMBIENT Ta=50.1℃
1	LF1	43.8℃	68.3℃
2	BD1	48.5℃	72.1℃
3	C5	49.4℃	73.0℃
4	D5	76.4℃	101.4℃
5	Q1	69.5℃	90.8℃
6	C35	52.2℃	75.1℃
7	T1coil	58.5℃	79.7℃
8	T1core	63.1℃	83.5℃
9	C105	57.3℃	79.4℃
10	C110	45.2℃	69.1℃
11	L100	55.8℃	78.4℃
12	Q100	80.7℃	103.6℃
13	U1	51.5℃	75.5℃
14	D30	51.3℃	74.9℃

3	LOW TEMPERATURE TURN ON TEST	TURN ON AFTER 2 HOUR	I/P： 264VAC/100VAC O/P：100 % LOAD Ta= -25 ℃	TEST：OK
4	HIGH HUMIDITY HIGH TEMPERATURE HIGH VOLTAGE TURN ON TEST	AFTER 12 HOURS IN CHAMBER ON CONTROL 50 ℃ NO DAMAGE	I/P： 272 VAC O/P：FULL LOAD Ta= 50 ℃ HUMIDITY= 95 %R.H	TEST：OK
5	TEMPERATURE COEFFICIENT	± 0.03 %/℃ (0~50℃)	I/P： 230 VAC O/P：FULL LOAD	±0.003%/℃ (0~50℃)
6	STORAGE TEMPERATURE TEST	1. Thermal shock Temperature： -40℃~ +85℃ 2. Temperature change rate ：25℃ / MIN 3. Dwell time low and high temperature ： 30 MIN/EACH 4. Total test cycle：5 CYCLE 5. Input/Output condition： STATIC		OK
7	THERMAL SHOCK TEST	1. Thermal shock Temperature： -30℃~ 70℃ 2. Temperature change rate ：25℃ / MIN 3. Dwell time low and high temperature ： 30 MIN/EACH 4. Total test cycle：10 CYCLE 5. Input/Output condition： 230VAC/Full Load AC ON/OFF TEST turn on 58sec；turn off 2sec		OK
8	VIBRATION TEST	1 Carton & 1 Set (1) Waveform： Sine Wave (2) Frequency：10~500Hz (3) Sweep Time：10min/sweep cycle (4) Acceleration：5G (5) Test Time：60min in each axis (X.Y.Z) (6) Ta：25℃		TEST：OK
9	CAPACITOR LIFE CYCLE	SUPPOSE C105 IS THE MOST CRITICAL COMPONENT (1) I/P： 230VAC O/P：FULL LOAD Ta= 25 ℃ LIFE TIME (2) I/P： 230VAC O/P：FULL LOAD Ta=50 ℃ LIFE TIME (3) I/P： 230VAC O/P：75% LOAD Ta= 50 ℃ LIFE TIME (4) I/P： 230VAC O/P：50% LOAD Ta= 50 ℃ LIFE TIME		(1) 325342HRS (2) 71815HRS (3) 117394HRS (4) 139640HRS
10	MTBF	MIL-HDBK-217F TOTAL FAILURE RATE：763.6KHRS		
11	DMTBF/Accelerated Life Test	Demonstration Mean Time Between Failure (Expected Life): Above 30,000 hours @ TA 50℃		

TEST RESULT	TESTER	APPROVAL
PASS	FRANK	WANGDZ

2007/3/20 A50-S014